

Maximum Ratings (@ $T_A = +25^{\circ}C$, unless otherwise specified.)

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V_{DSS}	75	V
Gate-Source Voltage			V_{GSS}	±20	V
Continuous Dusin Courset (Nata CVV - 40V	Steady State	T _A = +25°C T _A = +70°C	I _D	7.8 6.2	А
Continuous Drain Current (Note 6) V _{GS} = 10V	t<10s	T _A = +25°C T _A = +70°C	I _D	10.5 8.4	А
Pulsed Drain Current (10µs pulse, duty cycle = 1%)			I _{DM}	56	Α
Maximum Continuous Body Diode Forward Current (Note 6)			Is	2.1	Α
Avalanche Current, L = 0.1mH			I _{AS}	28.8	Α
Avalanche Energy, L = 0.1mH			E _{AS}	42.2	mJ

Thermal Characteristics (@T_A = +25°C, unless otherwise specified.)

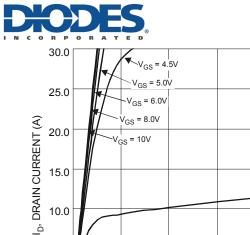
Characteristic	Symbol	Value	Units	
Total Power Dissipation (Note 5)		P_{D}	0.9	W
Thermal Desistance Innetion to Ambient (Note 5)	Steady state	1	125	°C/W
Thermal Resistance, Junction to Ambient (Note 5)	t<10s	$R_{\theta JA}$	67	
Total Power Dissipation (Note 6)		P _D	2	W
Thermal Desigtance, Junction to Ambient (Note 6)	Steady state		62	
Thermal Resistance, Junction to Ambient (Note 6)	t<10s	$R_{ heta JA}$	34	°C/W
Thermal Resistance, Junction to Case (Note 6)		$R_{ heta JC}$	6.9	
Operating and Storage Temperature Range		T _J , T _{STG}	-55 to +150	°C

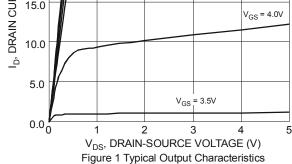
Electrical Characteristics (@TA = +25°C, unless otherwise specified.)

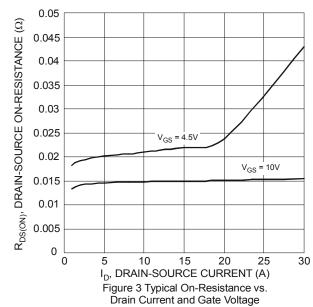
Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 7)							
Drain-Source Breakdown Voltage	BV _{DSS}	75		_	V	$V_{GS} = 0V$, $I_D = 250\mu A$	
Zero Gate Voltage Drain Current T _J = +25°C	I _{DSS}			1	μΑ	$V_{DS} = 75V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	_	_	±100	nA	$V_{GS} = \pm 20V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 7)							
Gate Threshold Voltage	$V_{GS(th)}$	1		3	٧	$V_{DS} = V_{GS}, I_{D} = 250 \mu A$	
Static Drain-Source On-Resistance		_	14.6	22	mΩ	$V_{GS} = 10V, I_D = 7.2A$	
Static Dialii-Source Off-Resistance	R _{DS(ON)}		20.5	28		$V_{GS} = 4.5V, I_D = 6.4A$	
Diode Forward Voltage	V _{SD}	_	0.72	_	V	$V_{GS} = 0V, I_S = 3.2A$	
DYNAMIC CHARACTERISTICS (Note 8)							
Input Capacitance	C _{iss}	-	2737	_	рF	N 051/ 1/ 01/	
Output Capacitance	Coss	_	126	_	pF	$V_{DS} = 35V, V_{GS} = 0V,$ - f = 1MHz	
Reverse Transfer Capacitance	C _{rss}	_	96.1	_	рF	71 - 1141112	
Gate Resistance	Rg	_	0.89	_	Ω	$V_{DS} = 0V$, $V_{GS} = 0V$, $f = 1MHz$	
Total Gate Charge (V _{GS} = 4.5V)	Qg	_	26.4	_	nC		
Total Gate Charge (V _{GS} = 10V)	Qg	_	56.5	_	nC	V _{DS} = 38V, I _D = 7.2A	
Gate-Source Charge	Qgs	_	12	_	nC		
Gate-Drain Charge	Q_{gd}	_	11.8	_	nC		
Turn-On Delay Time	t _{D(on)}	_	6.1	_	ns		
Turn-On Rise Time	t _r	_	5.7	_	ns	$V_{GS} = 10V, V_{DS} = 38V,$	
Turn-Off Delay Time	t _{D(off)}	_	19.6	_	ns	$R_G = 1\Omega, I_D = 5.7A$	
Turn-Off Fall Time	t _f	_	3.9	_	ns		
Body Diode Reverse Recovery Time	t _{rr}	_	26.2	_	ns		
Body Diode Reverse Recovery Charge	Q _{rr}	_	25.2	_	nC	$I_F = 5.7A$, di/dt = 100A/ μ s	

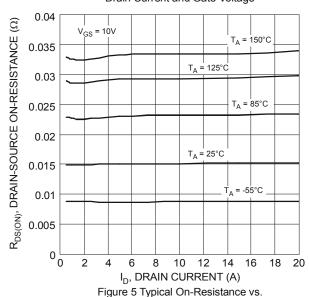
5. Device mounted on FR-4 PC board, with minimum recommended pad layout, single sided.

- 6. Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate 7. Short duration pulse test used to minimize self-heating effect.
- 8. Guaranteed by design. Not subject to product testing.

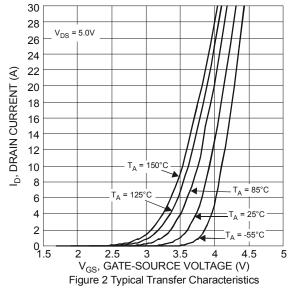


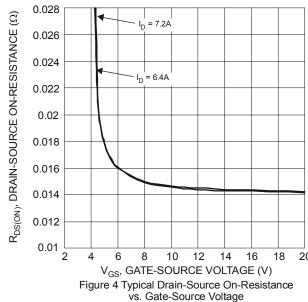






Drain Current and Temperature





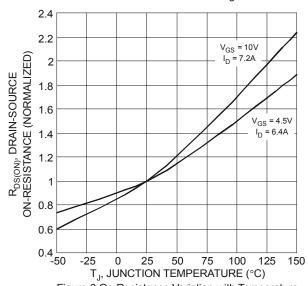
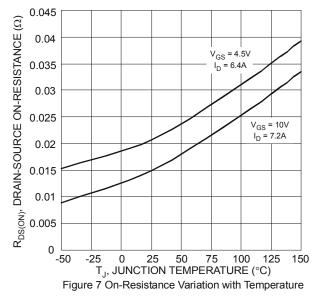
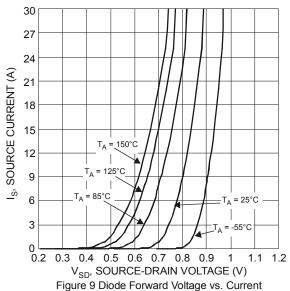
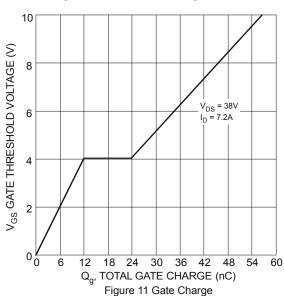


Figure 6 On-Resistance Variation with Temperature









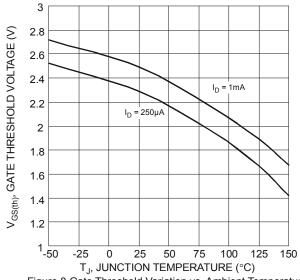
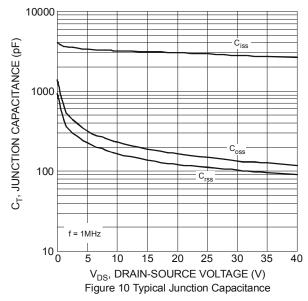
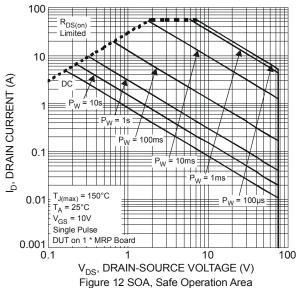
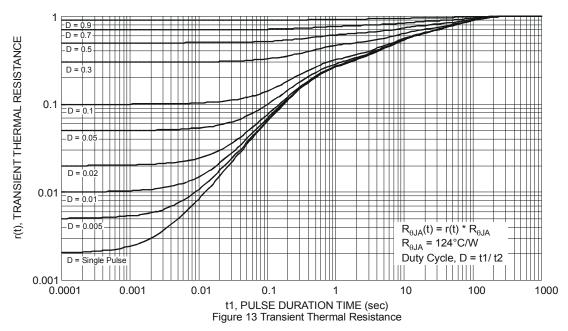


Figure 8 Gate Threshold Variation vs. Ambient Temperature



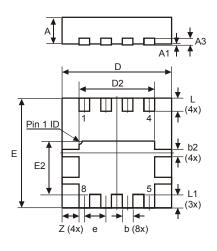






Package Outline Dimensions

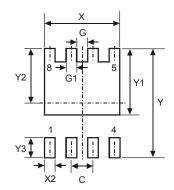
Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



POWERDI®3333-8					
Dim	Min Max		Тур		
D	3.25	3.35	3.30		
E	3.25	3.35	3.30		
D2	2.22	2.32	2.27		
E2	1.56	1.66	1.61		
Α	0.75	0.85	0.80		
A1	0	0.05	0.02		
A3	_	_	0.203		
b	0.27	0.37	0.32		
b2	_	_	0.20		
L	0.35	0.45	0.40		
L1	_	_	0.39		
е	_	_	0.65		
Ζ	_	_	0.515		
All Dimensions in mm					

Suggested Pad Layout

Please see AP02001 at http://www.diodes.com/datasheets/ap02001.pdf for the latest version.



Value (in mm)			
0.650			
0.230			
0.420			
3.700			
2.250			
1.850			
0.700			
2.370			
0.420			



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